


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/330,034	MIN-CHEN ET AL.	
	Examiner	Art Unit	
	Hien D. Vu	2833	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
439		534		439	569				
INTERNATIONAL CLASSIFICATION									
H01R		13160							
			/						
			/						
			/						
			/						

(Assistant Examiner) (Date) <i>[Signature]</i>		Total Claims Allowed: 8	
(Legal Instruments Examiner) (Date) <i>[Signature]</i> 27-06		O.G. Print Claim(s) 1 O.G. Print Fig. 142	

Hien Vu PRIMARY EXAMINER (Primary Examiner)				2/2/06 (Date)
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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